

Traceable Calibration of Silicon Single Photon Avalanche Diodes Using Synchrotron Radiation

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- **Electron storage rings as radiation sources with high dynamic range of the spectral radiant power
– the Metrology Light Source (MLS) of PTB**
- **Traceable calibration of Single Photon Avalanche Diodes (SPADs) using synchrotron radiation**
- **Outlook**

Important property of synchrotron radiation

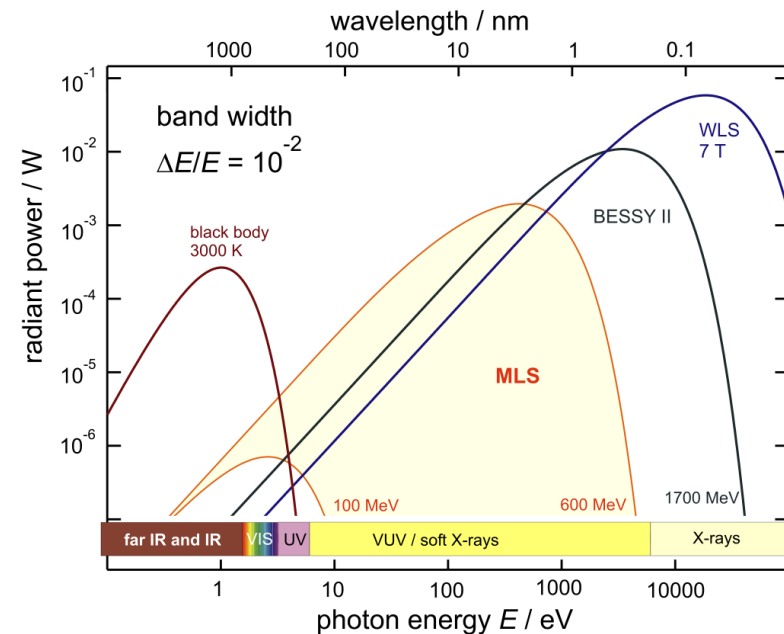
- For N electrons

$$\Phi_{\lambda}^{\text{Schwinger}}(\lambda, N_{e^{-}}) = N_{e^{-}} \Phi_{e^{-}, \lambda}^{\text{Schwinger}}(\lambda)(1 + \varepsilon(\lambda))$$

(incoherent operation)

Number of stored electrons changes
radiant power by 11 orders of magnitude
without changing the emitted spectrum

- $\varepsilon(\lambda)$ correction for finite vertical source size
(at MLS well below 10^{-4})

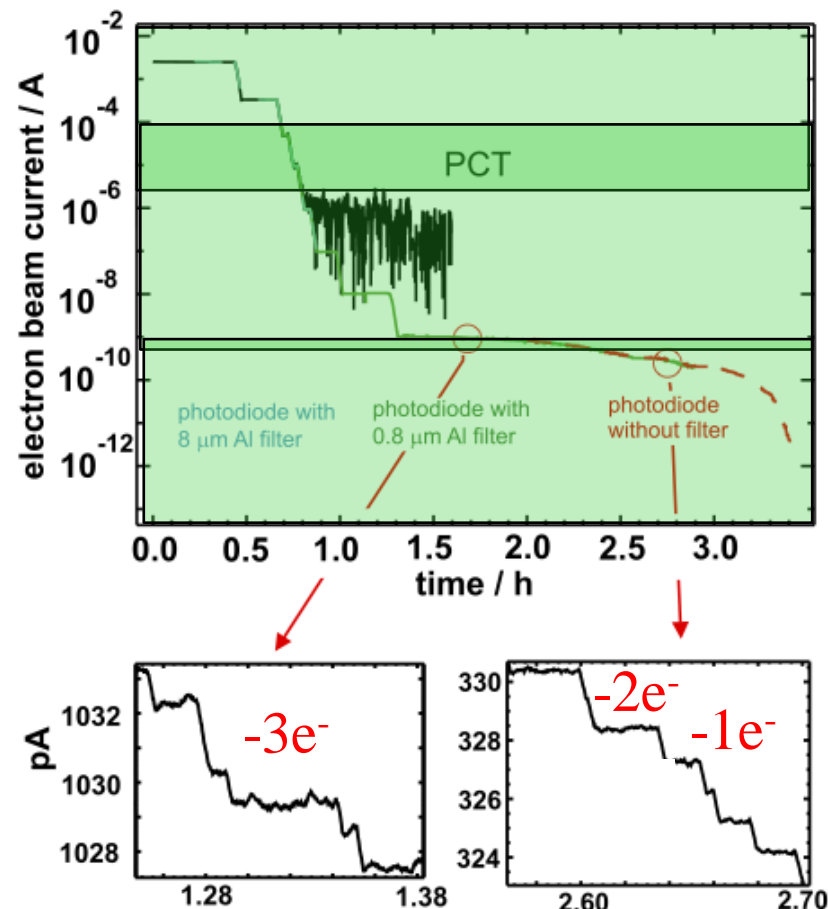


Measurement of the ring current

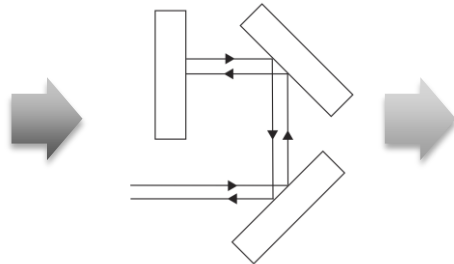
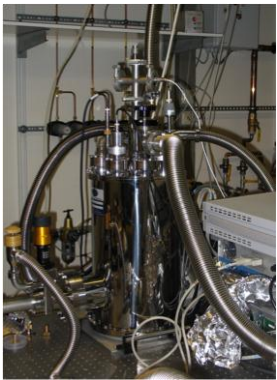
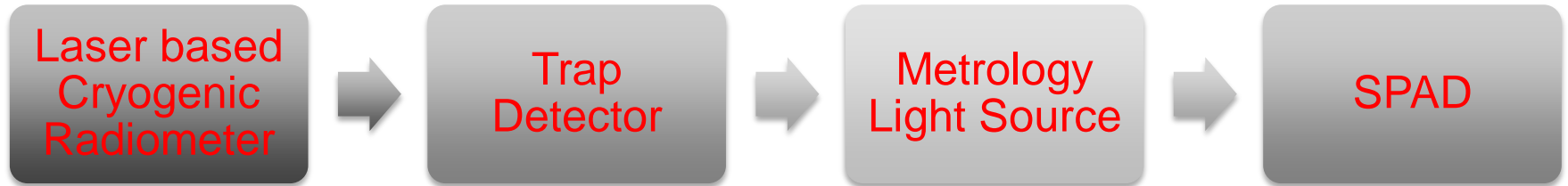
- Ring current range 200 mA to 1 mA
 - parametric current transformers
 - rel. uncertainty $2 \cdot 10^{-4}$

- Ring current range 1 mA to 1 nA
 - windowless Si-photodiodes with Al-filters
 - rel. uncertainty 2%

- Ring current < 1 nA
 - direct counting of electrons by discrete steps due to electron losses

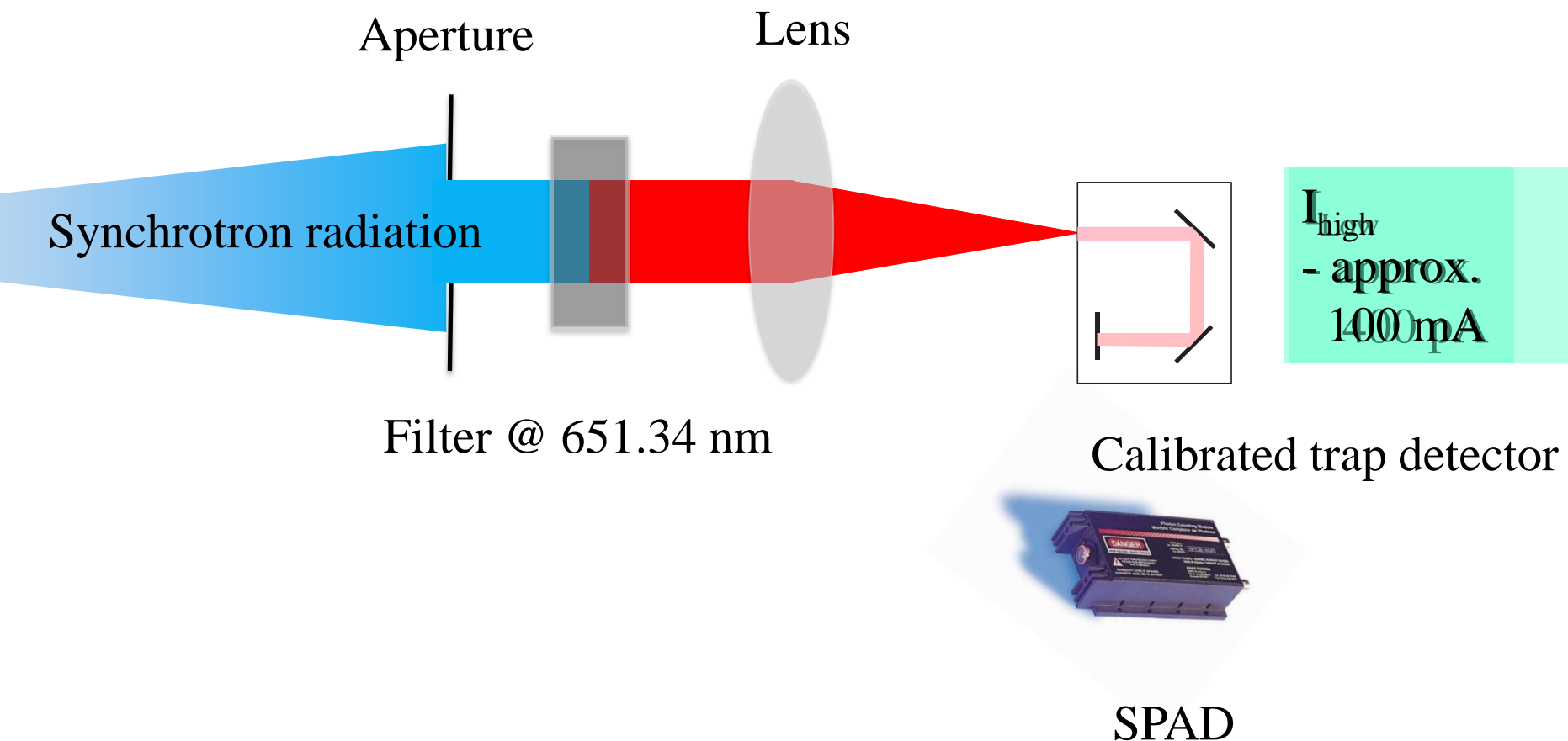


Calibration chain



- Huge dynamic range of the MLS (1 e⁻ to 10¹¹ e⁻ stored)
- Exploitation of the strict proportionality of ringcurrent and emitted radiation

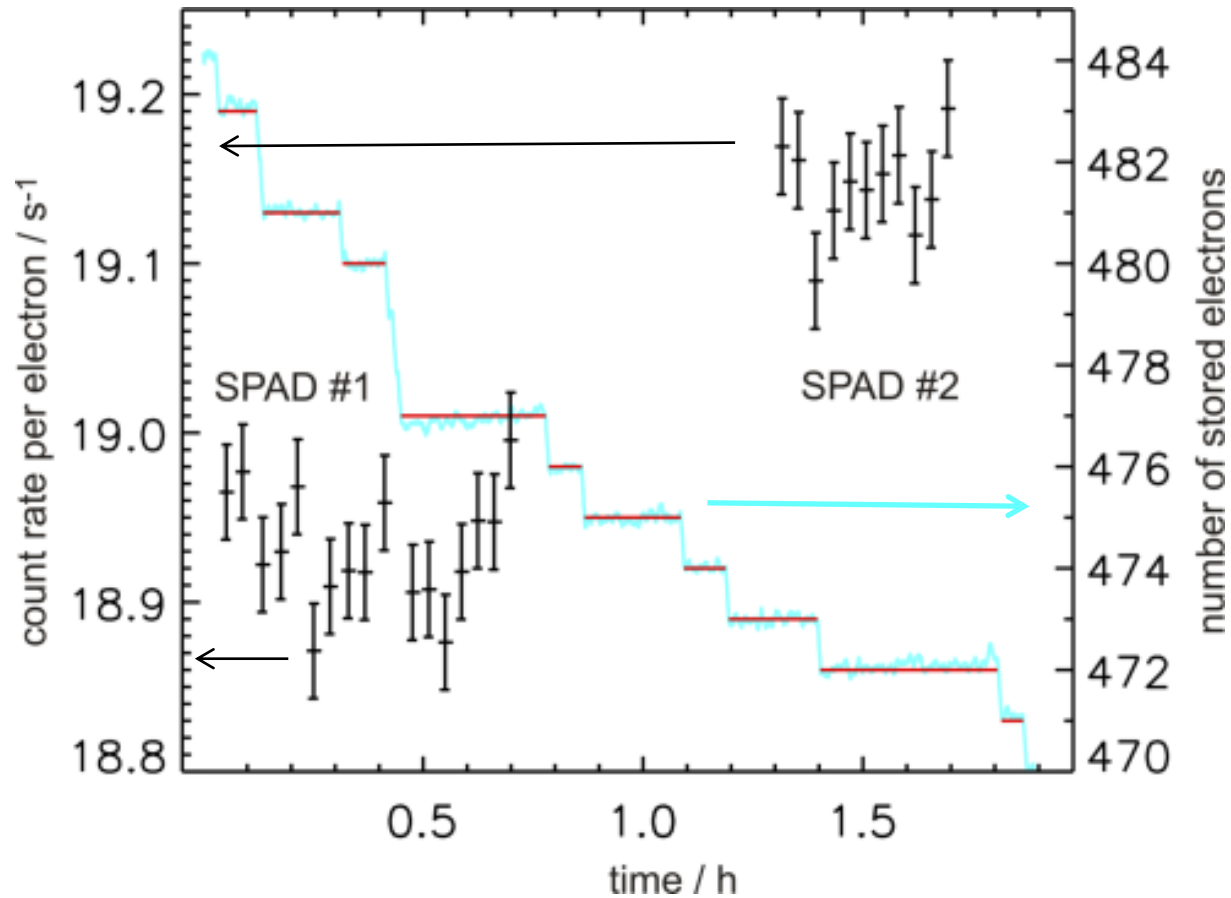
Calibration - setup



*photon rate*_{Trap} / *number of stored electrons* (I_{high})

$$QE_{SPAD}^* = \frac{\text{count rate}_{SPAD} / \text{number of stored electrons}(I_{low})}{\text{photon rate}_{Trap} / \text{number of stored electrons}(I_{high})}$$

Uncorrected quantum efficiency (QE^*)

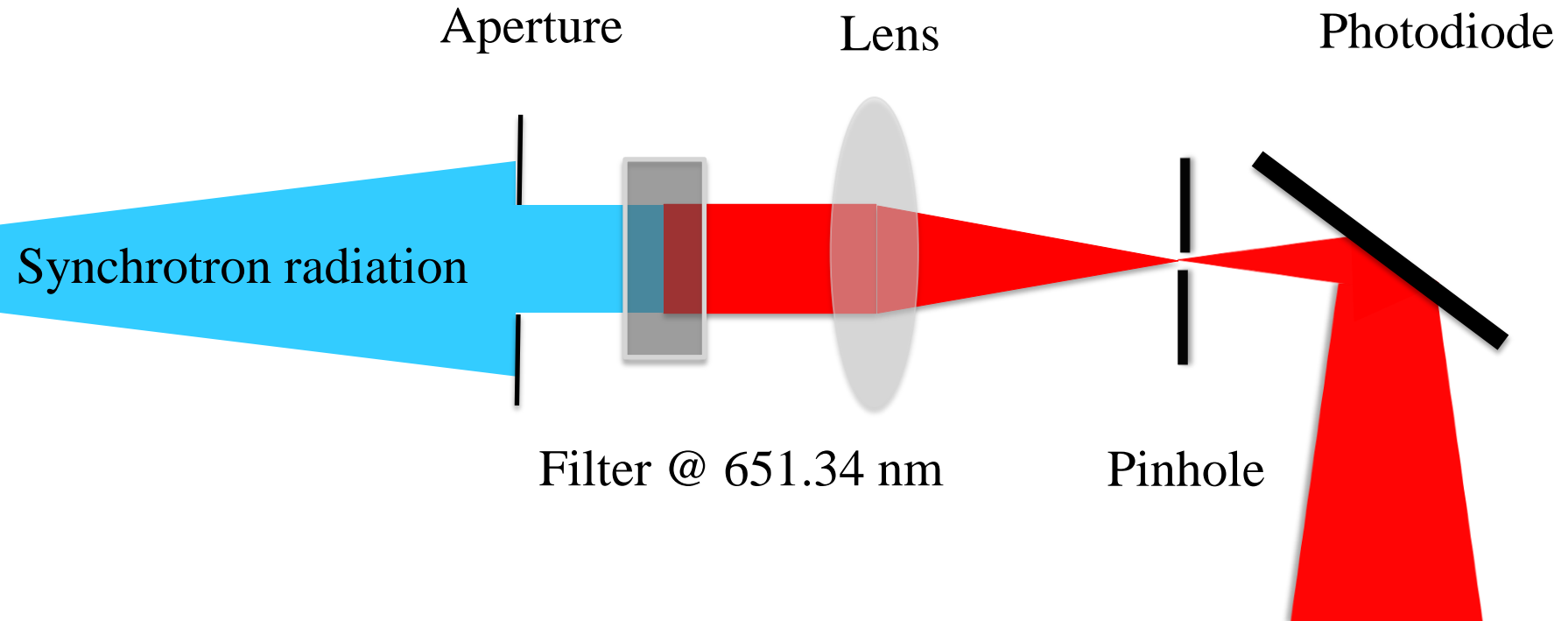


Uncorrected QE^* @ 651.34 nm:
SPAD1: 67.63 %
SPAD2: 68.39 %

Corrections

- **Different detector sizes of SPAD / trap detector**
- **Afterpulsing probability**
- **Bandwidth**
- **Dead time**
- **Photon statistic**

Calibration – detector size correction

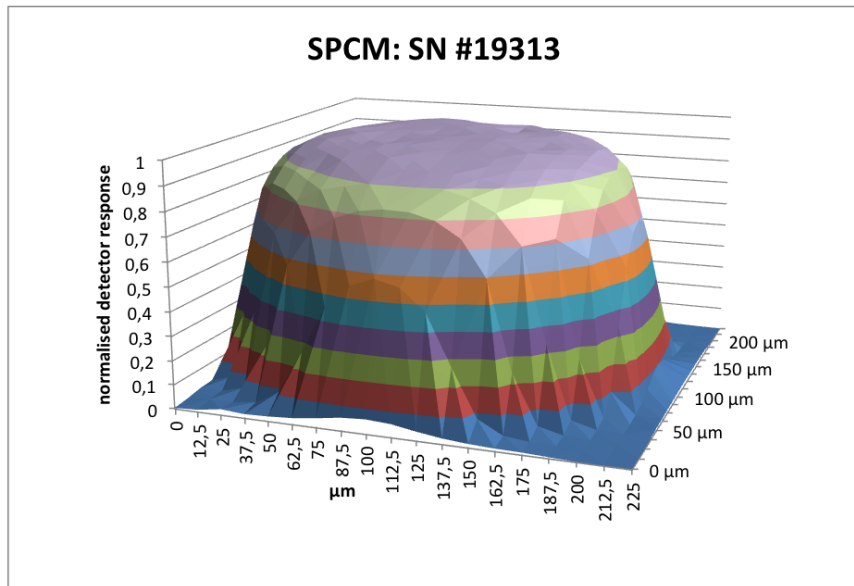


Pinhole \emptyset	∞	196 μm	149 μm
Losses	0%	3.7%	4.6%

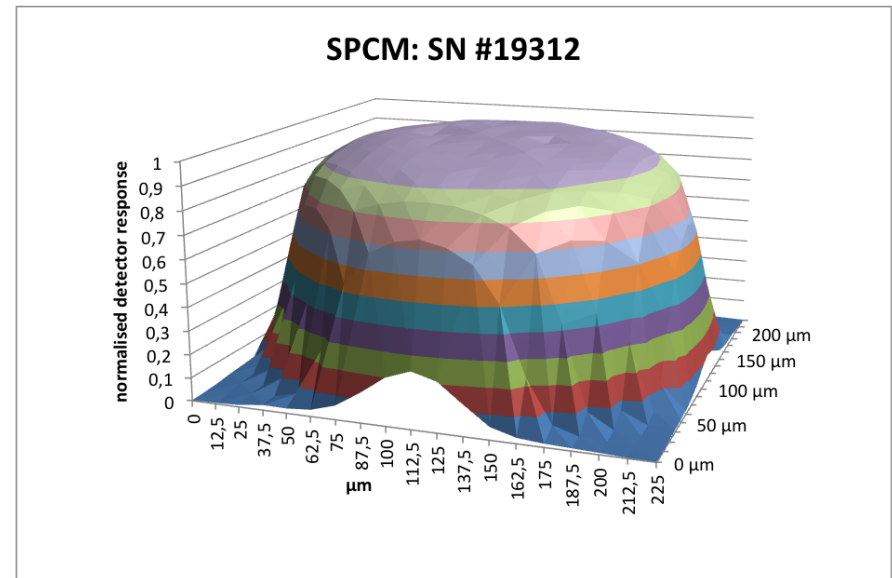
Data sheet: SPAD-diameter approx. 180 μm

Determination detector size SPADs

He-Ne laser @ 633 nm, focus diameter < 15 μm



SPAD1



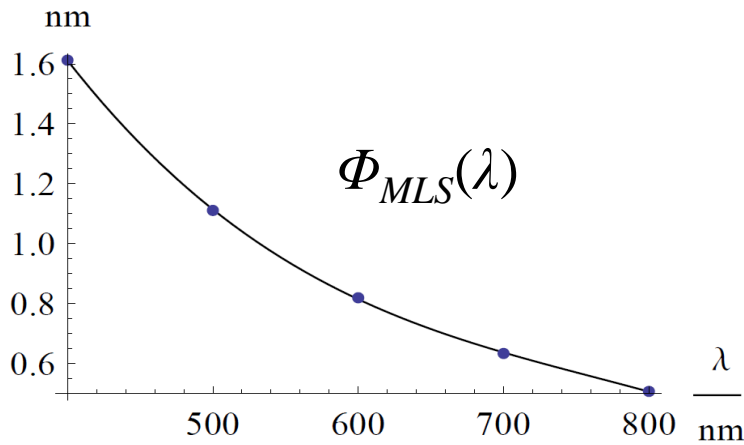
SPAD2

FWHM = 210 μm

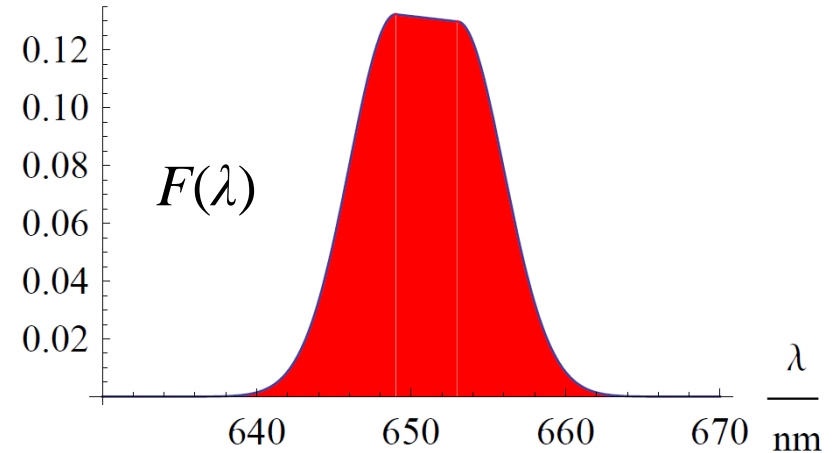
→ Correction factor detector sizes of SPAD and trap detector: 1.035

Bandwidth correction

photon rate

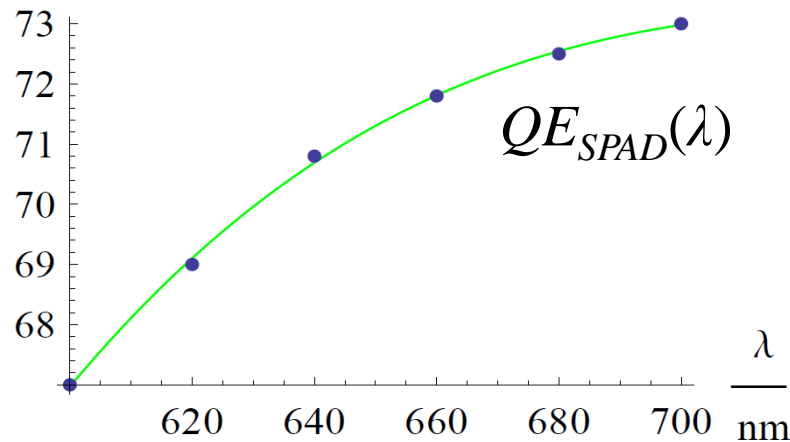


Arbitrary Units



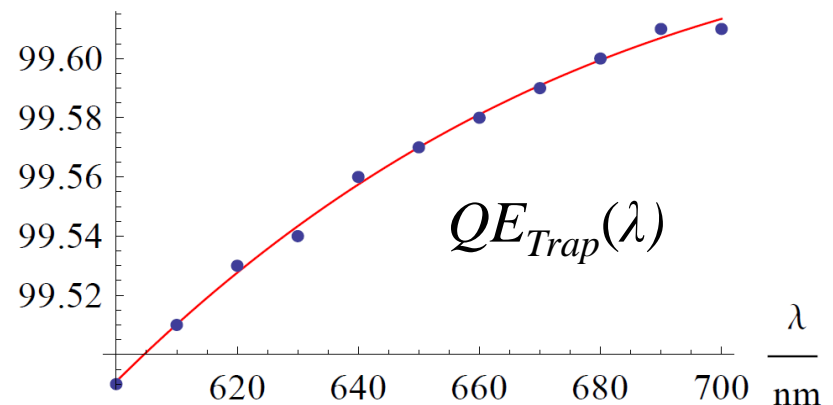
QE

Percent



QE

Percent



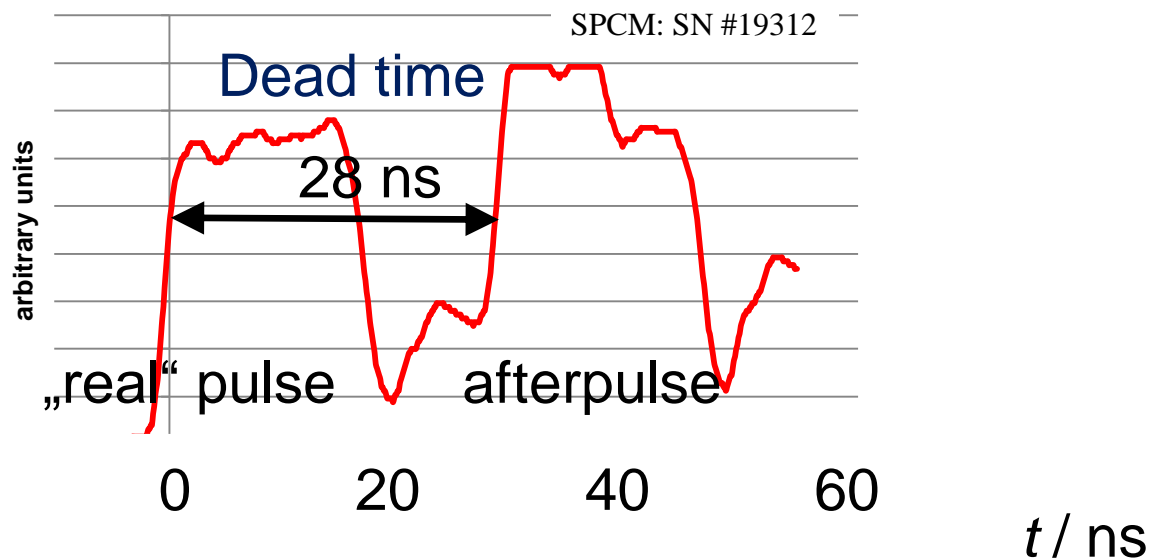
$$C_{Trap} = \frac{\int_0^1 F_{MLS}(\lambda) \cdot F(\lambda) \cdot QE_{Trap}(\lambda) \cdot d\lambda}{QE_{Trap}(651.34nm) \cdot \int_0^1 F_{MLS}(\lambda) \cdot F(\lambda) \cdot d\lambda}$$

$$C_{SPAD} = \frac{\int_{\lambda} \Phi_{MLS}(\lambda) \cdot F(\lambda) \cdot QE_{SPAD}(\lambda) \cdot d\lambda}{QE_{SPAD}(651.34nm) \cdot \int_{\lambda} \Phi_{MLS}(\lambda) \cdot F(\lambda) \cdot d\lambda}$$

$$C_{BW} = \frac{C_{SPAD}}{C_{Trap}} = 1.0004$$

Afterpulsing and dead time

- Afterpulsing probability
 - 0.14 % (SPAD1)
 - 0.07 % (SPAD2)
- Dead time
 - 28 ns



Uncertainty budget

Source of uncertainty	Correction factor	SPAD1	SPAD2
Count rate/e-		0.049%	0.047%
Ratio photocurrent trap detector to ring current, Type A		0.051%	0.051%
Ringcurrent measurement		0.048%	0.048%
Spectral responsivity		0.045%	0.045%
SPAD-positioning		0.020%	0.020%
Bandwidth	1.0004	0.019%	0.019%
Detector sizes	1.035	0.09%	0.09%
Statistic	1.00018	0.018%	
	1.00018		0.018%
Afterpulsing	0.998571	0.098%	
	0.999333		0.071%
Combined rel. uncertainty		0.18%	0.16%

	SPAD1	SPAD2
Quantum efficiency @ 651.34 nm	0.6984	0.7069
Relative standard uncertainty	0.18%	0.16%

- First determination of QE of SPADs with synchrotron radiation
- Method works in wide spectral range
- Measurement uncertainties comparable with the two existing methods:
 - SPDC: NIST 0.18%*, NPL 0.3%†
 - Substitution Method: NIST 0.17%*, NPL 0.2%‡

Outlook

- **Exploitation of method with fiber coupled detectors**
 - EMRP JRP IND-06 „Metrology for Industrial Quantum Communication“
- **Calibrations at telecom wavelengths**
- **Usage of superconducting single photon detectors**

Thank you for your attention